

Notice of References Cited	Application/Control No. 10/790,111	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner LEE D. WILSON	Art Unit 3723	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,315,638 B1	11-2001	Marukawa, Takabumi	451/36
	B	US-2003/0226378 A1	12-2003	Okuyama et al.	65/61
	C	US-2004/0166781 A1	08-2004	Yamada, Jiro	451/041
	D	US-6,632,547 B2	10-2003	Shimada, Takashi	428/848.8
	E	US-6,287,175 B1	09-2001	Marukawa et al.	451/41
	F	US-2003/0110803 A1	06-2003	Saito et al.	65/30.14
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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